

Freeform Search

Database:	US Pre-Grant Publication Full-Text Database US Patents Full-Text Database US OCR Full-Text Database EPO Abstracts Database JPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins
Term:	(near-field microscope) and (metal tip or metal point or metal member or metal probe)
Display:	<input type="text" value="10"/> Documents in Display Format: <input type="text" value="-"/> Starting with Number <input type="text" value="1"/>
Generate: <input type="radio"/> Hit List <input checked="" type="radio"/> Hit Count <input type="radio"/> Side by Side <input type="radio"/> Image	

Search History

DATE: Friday, December 10, 2004 [Printable Copy](#) [Create Case](#)

<u>Set</u> <u>Name</u>	<u>Query</u>	<u>Hit</u> <u>Count</u>	<u>Set</u> <u>Name</u> result set
side by side			
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ</i>			
<u>L7</u>	(near-field microscope) and (metal tip or metal point or metal member or metal probe)	5	<u>L7</u>
<i>DB=PGPB,USPT,USOC,EPAB,JPAB; PLUR=YES; OP=ADJ</i>			
<u>L6</u>	L3 and (polarizati\$4)	54	<u>L6</u>
<u>L5</u>	L3 and (metal member or metal point or metal tip or metal end)	14	<u>L5</u>
<u>L4</u>	L3 and (planar substrate or flat substrate)	22	<u>L4</u>
<u>L3</u>	L2 and (light source or laser or light beam)	248	<u>L3</u>
<u>L2</u>	L1 and "near-field"	294	<u>L2</u>
<u>L1</u>	(250/216,234,306,307,225,559.09;73/105;359/321,738)![CCLS]	8575	<u>L1</u>

END OF SEARCH HISTORY